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| Notice of References Cited | Application/Control No. 10/676,886 | Applicant(s)/Patent Under Reexamination JOHNSON, BRIAN P. | |
| | Examiner Craig E. Walter | Art Unit 2188 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-6,378,056 | 04-2002 | Nizar et al. | 711/170 |
| * | B | US-6,507,530 | 01-2003 | Williams et al. | 365/226 |
| * | C | US-2001/0039603 | 11-2001 | MANOWITZ, NEAL | 711/115 |
| * | D | US-2003/0061458 | 03-2003 | Wilcox et al. | 711/167 |
| * | E | US-2001/0026487 | 10-2001 | Koga, Yuichi | 365/202 |
| * | F | US-2003/0221072 | 11-2003 | Azevedo et al. | 711/154 |
| * | G | US-2005/0050266 | 03-2005 | Haas et al. | 711/112 |
| * | H | US-2004/0117581 | 06-2004 | Lee, Cheol-Ho | 711/170 |
| * | I | US-2003/0110368 | 06-2003 | Kartoz, Michael F. | 713/1 |
| * | J | US-2004/0064686 | 04-2004 | Miller et al. | 713/001 |
| * | K | US-6,336,176 | 01-2002 | Leyda et al. | 711/170 |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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